

BFQ17**CASE 345-01, STYLE 1**
SOT-89**RF TRANSISTOR**

NPN SILICON

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CEO}	25	V
Collector-Emitter Voltage (RBE $\leq 50 \Omega$)	V_{CER}	40	V
Collector-Base Voltage	V_{CBO}	40	V
Emitter-Base Voltage	V_{EBO}	2.0	V
Collector Current — Continuous	I_C	300	mA
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-55 to +150	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
*Total Device Dissipation, $T_A = 25^\circ\text{C}$ Derate above 25°C	P_D	1.0 8.0	Watt mW/°C
Storage Temperature	T_{stg}	150	°C
*Thermal Resistance Junction to Ambient	$R_{\theta JA}$	125	°C/W

*Package mounted on 99.5% alumina 10 x 12 x 0.6 mm.

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
Collector-Emitter Breakdown Voltage ($I_C = 10 \text{ mA}$)	$V_{(BR)CEO}$	25	—	V
Collector-Base Breakdown Voltage ($I_C = 10 \mu\text{A}$)	$V_{(BR)CBO}$	40	—	V
Emitter-Base Breakdown Voltage ($I_E = 10 \mu\text{A}$)	$V_{(BR)EBO}$	2.0	—	V
Collector Cutoff Current ($V_{CB} = 20 \text{ V}$) ($V_{CB} = 20 \text{ V}, T_A = 150^\circ\text{C}$)	I_{CBO}	— —	100 20	nA
Emitter Cutoff Current ($V_{EB} = 1.0 \text{ V}$)	I_{EBO}	—	100	nA
ON CHARACTERISTICS				
DC Current Gain ($I_C = 50 \text{ mA}, V_{CE} = 5.0 \text{ V}$) ($I_C = 150 \text{ mA}, V_{CE} = 5.0 \text{ V}$)	h_{FE}	25 25	— —	—
Collector-Emitter Saturation Voltage ($I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$)	$V_{CE(\text{sat})}$	—	0.5	V
SMALL-SIGNAL CHARACTERISTICS				
Current-Gain — Bandwidth Product ($V_{CE} = 15 \text{ V}, I_C = 150 \text{ mA}, f = 500 \text{ MHz}$)	f_T	1200(1)	—	MHz
Collector-Base Capacitance ($V_{CB} = 15 \text{ V}, f = 1.0 \text{ MHz}$)	C_{cb}	—	4.0	pF
Reverse Transfer Capacitance Common-Emitter ($V_{CE} = 15 \text{ V}, I_C = 10 \text{ mA}, f = 1.0 \text{ MHz}$)	C_{re}	—	1.9	pF

(1) Typical only